

ZXMN2F34MA 20V N-channel enhancement mode MOSFET in DFN322

Summary

V _{(BR)DSS}	$R_{DS(on)}\left(\Omega\right)$	I _D (A)
20	0.060 @ V _{GS} = 4.5V	8.5
	0.120 @ V _{GS} = 2.5V	

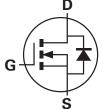


Description

This new generation Trench MOSFET from Zetex features low onresistance achievable with low (2.5V) gate drive. The 2mm x 2mm DFN package provides superior thermal performance versus alternative leaded devices

Features

- · Low on-resistance
- Superior thermal performance (versus to SOT23)
- · 2.5V gate drive capability
- · DFN 2x2 package

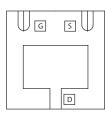


Applications

- Buck/Boost DC-DC Converters
- Motor Control
- · LED Lighting

Ordering information

DEVICE	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMN2F34MATA	7	8	3,000



Device marking

1M4

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain source voltage	V _{DSS}	20	V
Gate source voltage	V _{GS}	±12	V
Continous Drain Current @ V _{GS} =4.5; T _A =25°C ^(b)	I _D	5.1	А
@ V _{GS} =4.5; T _A =70°C ^(b)		4.1	Α
@ V _{GS} =4.5; T _A =25°C ^(a)		4.0	Α
@ V _{GS} =4.5; T _A =25°C ^(d)		8.5	Α
Pulsed drain current ^(c)	I _{DM}	19	Α
Continuous source current (body diode)(b)	I _S	3.1	Α
Pulsed source current (body diode)(c)	I _{SM}	19	Α
Power dissipation at T _A =25°C ^(a)	P _D	1.35	W
Linear derating factor		10.8	mW/°C
Power dissipation at T _A =25°C ^(b)	P _D	2.2	W
Linear derating factor		17.8	mW/°C
Power dissipation at T _A =25°C ^(d)	P _D	6.6	W
Linear derating factor		52.9	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	92.5	°C/W
Junction to ambient ^(b)	$R_{\Theta JA}$	56	°C/W
Junction to lead ^(d)	$R_{\Theta JL}$	18.9	°C/W

NOTES:

⁽a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions

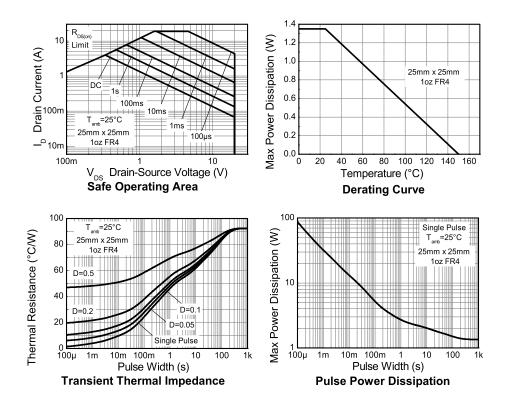
⁽b) For a device surface mounted on FR4 PCB measured at t $\! \leq \! 5$ sec.

⁽c) Repetitive rating - 25mm x 25mm FR4 PCB, D=0.02, pulse width 300µs - pulse width limited by maximum junction temperature.

⁽d) Thermal resistance from junction to solder-point (at end of drain lead).

ZXMN2F34MA

Thermal characteristics



Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Static				•		1	
Drain-Source breakdown voltage	V _{(BR)DSS}	20			V	I _D = 250μA, V _{GS} =0V	
Zero gate voltage drain current	I _{DSS}			1	μА	V _{DS} = 20V, V _{GS} =0V	
Gate-Body leakage	I _{GSS}			100	nA	V _{GS} =±12V, V _{DS} =0V	
Gate-Source threshold voltage	V _{GS(th)}	0.5	0.8	1.5	V	I _D = 250μA, V _{DS} =V _{GS}	
Static Drain-Source on-state resistance (*)	R _{DS(on)}			0.060 0.120	Ω Ω	V _{GS} = 4.5V, I _D = 2.5A V _{GS} = 2.5V, I _D = 1.0A	
Forward transconductance ^{(*)(†)}	9 _{fs}		7.5		S	V _{DS} = 10V, I _D = 2.5A	
Dynamic (†)							
Input capacitance	C _{iss}		277		pF		
Output capacitance	C _{oss}		65		pF	V _{DS} = 10V, V _{GS} =0V f=1MHz	
Reverse transfer capacitance	C _{rss}		35		pF	- I = IIVITZ	
Switching (‡)(†)							
Turn-on-delay time	t _{d(on)}		2.65		ns		
Rise time	t _r		4.2		ns	V _{DD} = 10V, V _{GS} = 4.5V I _D = 1A	
Turn-off delay time	t _{d(off)}		9.9		ns	$R_{\rm G} \approx 6.0\Omega$	
Fall time	t _f		5.1		ns		
Total gate charge	Q_g		2.8		nC	V _{DS} = 10V, V _{GS} = 4.5V	
Gate-Source charge	Q _{gs}		0.61		nC	I _D = 2.5A	
Gate Drain charge	O _{gd}		0.63		nC]	
Source-drain diode			•	•			
Diode forward voltage ^(*)	V_{SD}		0.73	1.2	V	I _S = 1.25A, V _{GS} =0V	
Reverse recovery time ^(†)	t _{rr}		6.5		ns	T _j =25°C, I _F =1.65A	
Reverse recovery charge ^(†)	Q _{rr}		1.4		nC	di/dt=100A/μs	

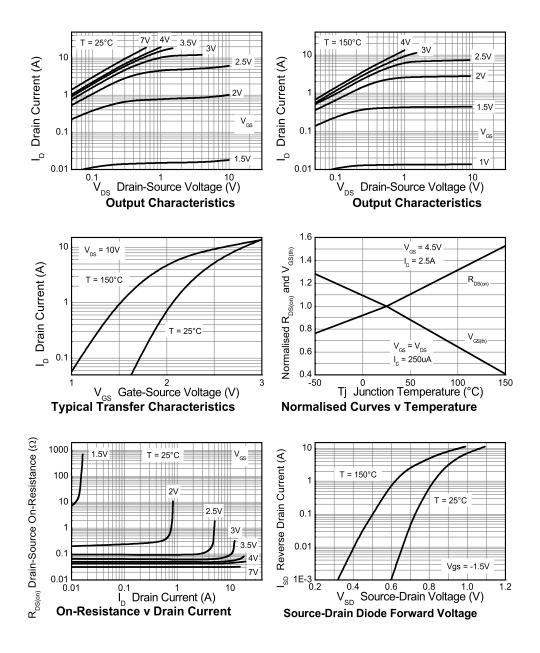
NOTES:

^(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

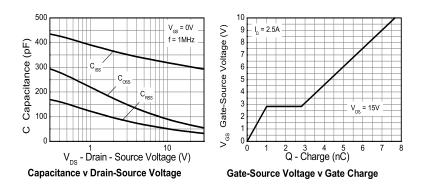
^(†) For design aid only, not subject to production testing.

^(‡) Switching characteristics are independent of operating junction temperature.

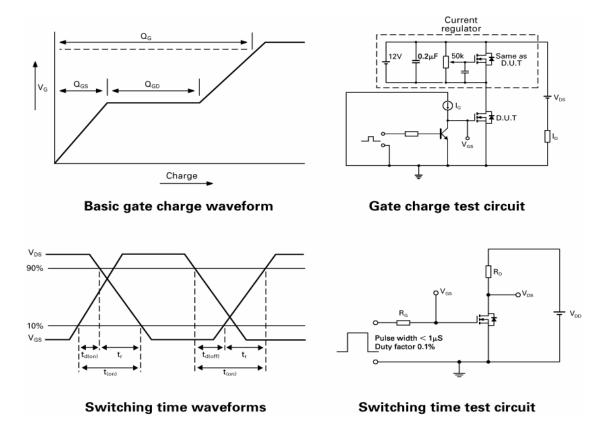
Typical characteristics



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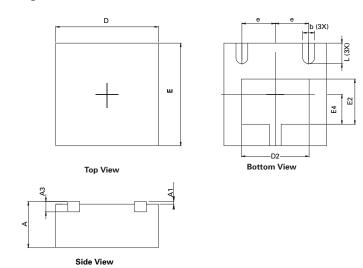
Test circuits



Issue 3 - May 2008 6 www.zetex.com

ZXMN2F34MA

Package outline - DFN322



DIM	Millin	neters	Inc	hes	DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.80	1.00	0.0315	0.0393	D2	1.22	1.42	0.0480	0.0559
A1		0.05		0.002	е	0.65 BSC.		0.02559 BSC	
A3	0.153	0.253	0.0060	0.0099	Е	1.900	2.100	0.0748	0.0826
b	0.180	0.300	0.0071	0.0118	E2	0.780	0.990	0.0307	0.0389
D	1.900	2.100	0.0748	0.0826	E4	0.480	0.680	0.0189	0.0267
					L	0.300	0.500	0.0118	0.0196

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

ZXMN2F34MA

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8

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